

Notice of References Cited	Application/Control No. 10/595,627		Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner Thuy N. Pardo		Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,142,521	08-1992	Terashima et al.	369/47.19
*	B	US-5,526,335	06-1996	Tamegai, Masahiro	369/53.16
*	C	US-5,872,955	02-1999	Asano, Hideo	711/202
*	D	US-6,525,894	02-2003	Nakamura, Hideki	360/49
*	E	US-6,813,227	11-2004	Cho et al.	369/44.28
*	F	US-7,126,784	10-2006	Tamura et al.	360/78.04
*	G	US-7,233,547	06-2007	Teraoka et al.	369/13.06
*	H	US-2006/0146666	07-2006	Ueda et al.	369/047.1
*	I	US-2006/0153037	07-2006	Koda et al.	369/053.21
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.